Overmyer et al. Shen et al. Shu-Validation et al.	0.1225 0.1265 0.7561	0.2952	 0.13	[-0.30; 0.55] [-0.45; 0.71]	40.5% 21.8%
Shu-Validation et al. Random effects mode	0.7561	0.5313		[-0.29; 1.80] [-0.22; 0.32]	6.7%

-1.5 -1 -0.5 0 0.5

Standardised Mean

Difference

SMD

95%-CI Weight

[-0.33; 0.43]

Random effects model **Prediction interval**

Heterogeneity: $I^2 = 0\%$, p = 0.53

Study

SMD SE(SMD)